

# Is Now Part of



# ON Semiconductor®

# To learn more about ON Semiconductor, please visit our website at www.onsemi.com

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (\_), the underscore (\_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (\_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at <a href="www.onsemi.com">www.onsemi.com</a>. Please email any questions regarding the system integration to Fairchild <a href="general-regarding-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-numbers-n

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officer



March 2000 Revised June 2005

# 74VCX164245

# **Low Voltage 16-Bit Dual Supply Translating Transceiver with 3-STATE Outputs**

# **General Description**

The VCX164245 is a dual supply, 16-bit translating transceiver that is designed for two way asynchronous communication between busses at different supply voltages by providing true signal translation. The supply rails consist of V<sub>CCB</sub>, which is the higher potential rail operating at 2.3V to 3.6V and V<sub>CCA</sub>, which is the lower potential rail operating at 1.65V to 2.7V. (V<sub>CCA</sub> must be less than or equal to V<sub>CCB</sub> for proper device operation.) This dual supply design allows for translation from 1.8V to 2.5V busses to busses at a higher potential, up to 3.3V.

The Transmit/Receive  $(T/\overline{R})$  input determines the direction of data flow. Transmit (active-HIGH) enables data from A Ports to B Ports. Receive (active-LOW) enables data from B Ports to A Ports. The Output Enable  $(\overline{OE})$  input, when HIGH, disables both A and B Ports by placing them in a High-Z condition. The A Port interfaces with the lower voltage bus (1.8V-2.5V). The B Port interfaces with the higher voltage bus (2.7V-3.3V). Also the VCX164245 is designed so that the control pins  $(T/\overline{R}_n, \overline{OE}_n)$  are supplied by  $V_{CCB}$ .

The 74VCX164245 is suitable for mixed voltage applications such as notebook computers using a 1.8V CPU and 3.3V peripheral components. It is fabricated with an Advanced CMOS technology to achieve high speed operation while maintaining low CMOS power dissipation.

# **Features**

- Bidirectional interface between busses ranging from 1.65V to 3.6V
- Supports Live Insertion and Withdrawal (Note 1)
- Static Drive (I<sub>OH</sub>/I<sub>OL</sub>)
  - ±24 mA @ 3.0V V<sub>CC</sub>
  - ±18 mA @ 2.3V V<sub>CC</sub>
  - ±6 mA @ 1.65V V<sub>CC</sub>
- Uses proprietary noise/EMI reduction circuitry
- Functionally compatible with 74 series 16245
- Latchup performance exceeds 300 mA
- ESD performance:

Human Body Model >2000V

Machine model >200V

Also packaged in plastic Fine-Pitch Ball Grid Array (FBGA)

**Note 1:** To ensure the high impedance state during power up or power down,  $OE_n$  should be tied to  $V_{CCB}$  through a pull up resistor. The minimum value of the resistor is determined by the current sourcing capability of the

# **Ordering Code:**

Order Number	Package Number	Package Description
74VCX164245G (Note 2)(Note 3)	BGA54A	54-Ball Fine-Pitch Ball Grid Array (FBGA), JEDEC MO-205, 5.5mm Wide
74VCX164245MTD (Note 3)	MTD48	48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

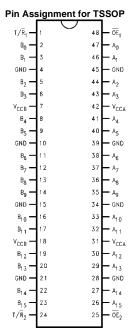
Note 2: Ordering Code "G" indicates Trays.

Note 3: Device also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code

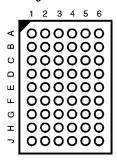
## **Logic Diagram**



# **Connection Diagrams**



#### Pin Assignment for FBGA



(Top Through View)

# **Pin Descriptions**

Pin	Names	Description
ΟE <sub>n</sub>		Output Enable Input (Active LOW)
$T/\overline{R}_r$	1	Transmit/Receive Input
$\overline{OE}_n$ $T/\overline{R}_r$ $A_0-t$ $B_0-t$ $NC$	A <sub>15</sub>	Side A Inputs or 3-STATE Outputs
B <sub>0</sub> –	3 <sub>15</sub>	Side B Inputs or 3-STATE Outputs
NC		No Connect

# **FBGA Pin Assignments**

	1	2	3	4	5	6
Α	B <sub>0</sub>	NC	T/R <sub>1</sub>	OE <sub>1</sub>	NC	A <sub>0</sub>
В	B <sub>2</sub>	B <sub>1</sub>	NC	NC	A <sub>1</sub>	A <sub>2</sub>
С	B <sub>4</sub>	B <sub>3</sub>	V <sub>CCB</sub>	$V_{CCA}$	A <sub>3</sub>	A <sub>4</sub>
D	B <sub>6</sub>	B <sub>5</sub>	GND	GND	A <sub>5</sub>	A <sub>6</sub>
E	B <sub>8</sub>	B <sub>7</sub>	GND	GND	A <sub>7</sub>	A <sub>8</sub>
F	B <sub>10</sub>	B <sub>9</sub>	GND	GND	A <sub>9</sub>	A <sub>10</sub>
G	B <sub>12</sub>	B <sub>11</sub>	V <sub>CCB</sub>	V <sub>CCA</sub>	A <sub>11</sub>	A <sub>12</sub>
Н	B <sub>14</sub>	B <sub>13</sub>	NC	NC	A <sub>13</sub>	A <sub>14</sub>
J	B <sub>15</sub>	NC	T/R <sub>2</sub>	OE <sub>2</sub>	NC	A <sub>15</sub>

# **Truth Tables**

Inp	uts				
OE <sub>1</sub>	T/R <sub>1</sub>	Outputs			
L	L	Bus B <sub>0</sub> –B <sub>7</sub> Data to Bus A <sub>0</sub> –A <sub>7</sub>			
L	Н	Bus A <sub>0</sub> -A <sub>7</sub> Data to Bus B <sub>0</sub> -B <sub>7</sub>			
Н	X	HIGH Z State on A <sub>0</sub> -A <sub>7</sub> , B <sub>0</sub> -B <sub>7</sub>			

Inp	uts	
OE <sub>2</sub>	T/R <sub>2</sub>	Outputs
L	L	Bus B <sub>8</sub> –B <sub>15</sub> Data to Bus A <sub>8</sub> –A <sub>15</sub>
L	Н	Bus A <sub>8</sub> -A <sub>15</sub> Data to Bus B <sub>8</sub> -B <sub>15</sub>
Н	X	HIGH-Z State on A <sub>8</sub> -A <sub>15</sub> , B <sub>8</sub> -B <sub>15</sub>

- H = HIGH Voltage Level
- L = LOW Voltage Level
- X = Immaterial (HIGH or LOW, inputs may not float)
- Z = High Impedance

#### Translator Power Up Sequence Recommendations

To guard against power up problems, some simple guidelines need to be adhered to. The VCX164245 is designed so that the control pins  $(T/\overline{R}_n, \overline{OE}_n)$  are supplied by  $V_{CCB}$ . Therefore the first recommendation is to begin by powering up the control side of the device,  $V_{CCB}$ . The  $\overline{OE}_n$  control pins should be ramped with or ahead of  $V_{CCB}$ , this will guard against bus contentions and oscillations as all A Port and B Port outputs will be disabled. To ensure the high impedance state during power up or power down,  $\overline{OE}_n$  should be tied to  $V_{CCB}$  through a pull up resistor. The minimum value of the resistor is determined by the current

sourcing capability of the driver. Second, the  $T/\overline{R}_n$  control pins should be placed at logic low (0V) level, this will ensure that the B-side bus pins are configured as inputs to help guard against bus contention and oscillations. B-side Data Inputs should be driven to a valid logic level (0V or  $V_{CCB}$ ), this will prevent excessive current draw and oscillations.  $V_{CCA}$  can then be powered up after  $V_{CCB}$ , but should never exceed the  $V_{CCB}$  voltage level. Upon completion of these steps the device can then be configured for the users desired operation. Following these steps will help to prevent possible damage to the translator device as well as other system components.

# 

Please note that these diagrams are provided only for the understanding of logic operations and should not be used to estimate propagation delays.

#### **Absolute Maximum Ratings**(Note 4) **Recommended Operating**

-0.5V to +4.6V

±50 mA

# Conditions (Note 6)

Supply Voltage	
Vcca	_

-0.5V to V<sub>CCB</sub>  $V_{CCA}$ 

-0.5V to 4.6V $V_{CCB}$ DC Input Voltage (V<sub>I</sub>) -0.5V to +4.6V

DC Output Voltage (V<sub>I/O</sub>) Outputs 3-STATE

Outputs Active (Note 5)

-0.5V to  $V_{CCA} + 0.5V$ An

Bn -0.5V to  $V_{CCB} + 0.5V$ 

DC Input Diode Current (I<sub>IK</sub>)

 $V_{I} < 0V$ -50 mA

DC Output Diode Current (I<sub>OK</sub>)

 $V_{O} < 0V$ -50 mA +50 mA  $V_O > V_{CC} \\$ 

DC Output Source/Sink Current

 $(I_{OH}/I_{OL})$ 

 $DC \ V_{CC} \ or \ Ground \ Current$ ±100 mA

Supply Pin (I<sub>CC</sub> or Ground)

Storage Temperature  $(T_{STG})$ -65°C to +150°C

Power Supply (Note 7)

1.65V to 2.7V  $V_{CCA}$ 2.3V to 3.6V  $V_{CCB}$ 0V to  $V_{\mbox{\scriptsize CCB}}$ 

Input Voltage (V<sub>I</sub>) @ OE, T/R Input/Output Voltage (V<sub>I/O</sub>)

0V to  $V_{\text{CCA}}$  $A_n$ 

 $B_n$ 0V to  $V_{CCB}$ 

Output Current in I<sub>OH</sub>/I<sub>OL</sub>

 $V_{CCA} = 2.3V$  to 2.7V±18 mA  $V_{CCA} = 1.65V \text{ to } 1.95V$ ±6 mA

 $V_{CCB} = 3.0V$  to 3.6V±24 mA

 $V_{CCB} = 2.3V$  to 2.7V±18 mA Free Air Operating Temperature (T<sub>A</sub>) -40°C to +85°C

Minimum Input Edge Rate ( $\Delta t/\Delta V$ )

 $V_{IN}$  = 0.8V to 2.0V,  $V_{CC}$  = 3.0V

Note 4: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Note 5:  $I_{\rm O}$  Absolute Maximum Rating must be observed.

Note 6: Unused inputs or I/O pins must be held HIGH or LOW. They may

Note 7: Operation requires:  $V_{CCA} \le V_{CCB}$ 

# DC Electrical Characteristics (1.65V < $V_{CCA} \leq$ 1.95V, 2.3V < $V_{CCB} \leq$ 2.7V)

Symbol	Parameter		Conditions	V <sub>CCA</sub> (V)	V <sub>CCB</sub> (V)	Min	Max	Units
$V_{IHA}$	HIGH Level Input Voltage	A <sub>n</sub>		1.65-1.95	2.3-2.7	0.65 x V <sub>CC</sub>		V
$V_{IHB}$		B <sub>n</sub> , T/R, OE		1.65-1.95	2.3-2.7	1.6		V
V <sub>ILA</sub>	LOW Level Input Voltage	A <sub>n</sub>		1.6-1.95	2.3-2.7		0.35 x V <sub>CC</sub>	V
V <sub>ILB</sub>		B <sub>n</sub> , T/R, OE		1.65-1.95	2.3-2.7		0.7	V
V <sub>OHA</sub>	HIGH Level Output Voltag	e	I <sub>OH</sub> = -100 μA	1.65-1.95	2.3-2.7	V <sub>CCA</sub> -0.2		V
			$I_{OH} = -6 \text{ mA}$	1.65	2.3-2.7	1.25		V
V <sub>OHB</sub>	HIGH Level Output Voltag	е	I <sub>OH</sub> = -100 μA	1.65-1.95	2.3-2.7	V <sub>CCB</sub> -0.2		V
			I <sub>OH</sub> = -18 mA	1.65-1.95	2.3	1.7		•
V <sub>OLA</sub>	LOW Level Output Voltage		I <sub>OL</sub> = 100 μA	1.65-1.95	2.3-2.7		0.2	V
			I <sub>OL</sub> = 6 mA	1.65	2.3-2.7		0.3	v
V <sub>OLB</sub>	LOW Level Output Voltage	)	I <sub>OL</sub> = 100 μA	1.65-1.95	2.3-2.7		0.2	V
			I <sub>OL</sub> = 18 mA	1.65-1.95	2.3		0.6	V
I	Input Leakage Current @	OE, T/R	$0V \leq V_I \leq 3.6V$	1.65-1.95	2.3-2.7		±5.0	μА
l <sub>OZ</sub>	3-STATE Output Leakage		$\frac{\text{OV} \le \text{V}_{\text{O}} \le 3.6\text{V}}{\text{OE}} = \text{V}_{\text{CCB}}$ $\text{V}_{\text{I}} = \text{V}_{\text{IH}} \text{ or V}_{\text{IL}}$	1.65-1.95	2.3-2.7		±10	μА
l <sub>OFF</sub>	Power OFF Leakage Curr	ent	$0 \le (V_I, V_O) \le 3.6V$	0	0		10	μА
I <sub>CCA</sub> /I <sub>CCB</sub>	Quiescent Supply Current per supply, V <sub>CCA</sub> / V <sub>CCB</sub>	i	$A_n = V_{CCA}$ or GND $B_n$ , $\overline{OE}$ , & $T/\overline{R} = V_{CCB}$ or GND	1.65–1.95	2.3-2.7		20	μА
			$\begin{aligned} &V_{CCA} \leq A_n \leq 3.6V \\ &V_{CCB} \leq B_n, \ \overline{OE}, \ T/\overline{R} \leq 3.6V \end{aligned}$	1.65–1.95	2.3–2.7		±20	μА
$\Delta I_{CC}$	Increase in I <sub>CC</sub> per Input, I	B <sub>n</sub> , T/R, OE	$V_I = V_{CCB} - 0.6V$	1.65-1.95	2.3-2.7		750	μА
	Increase in I <sub>CC</sub> per Input,	A <sub>n</sub>	$V_I = V_{CCA} - 0.6V$	1.65-1.95	2.3-2.7		750	μА
				1		1		

# DC Electrical Characteristics (1.65V < $V_{\text{CCA}} \leq$ 1.95V, 3.0V < $V_{\text{CCB}} \leq$ 3.6V)

Symbol	Para	meter	Conditions	V <sub>CCA</sub> (V)	V <sub>CCB</sub> (V)	Min	Max	Units
V <sub>IHA</sub>	HIGH Level	A <sub>n</sub>		1.65-1.95	3.0-3.6	0.65 x V <sub>CC</sub>		V
$V_{IHB}$	Input Voltage	$B_n$ , $T/\overline{R}$ , $\overline{OE}$		1.65-1.95	3.0-3.6	2.0		V
V <sub>ILA</sub>	LOW Level	A <sub>n</sub>		1.65–1.95	3.0-3.6		0.35 x V <sub>CC</sub>	V
$V_{ILB}$	Input Voltage	B <sub>n</sub> , T/R, OE		1.65-1.95	3.0-3.6		0.8	V
V <sub>OHA</sub>	HIGH Level Output	Voltage	I <sub>OH</sub> = -100 μA	1.65–1.95	3.0-3.6	V <sub>CCA</sub> -0.2		V
			$I_{OH} = -6 \text{ mA}$	1.65	3.0-3.6	1.25		•
V <sub>OHB</sub>	HIGH Level Output	Voltage	I <sub>OH</sub> = -100 μA	1.65–1.95	3.0-3.6	V <sub>CCA</sub> -0.2		V
			I <sub>OH</sub> = -24 mA	1.65-1.95	3.0	2.2		•
V <sub>OLA</sub>	LOW Level Output	Voltage	$I_{OL} = 100 \mu A$	1.65–1.95	3.0-3.6		0.2	V
			I <sub>OL</sub> = 6 mA	1.65	3.0-3.6		0.3	V
V <sub>OLB</sub>	LOW Level Output	Voltage	I <sub>OL</sub> = 100 μA	1.65-1.95	3.0-3.6		0.2	V
			I <sub>OL</sub> = 24 mA	1.65–1.95	3.0		0.55	•
I	Input Leakage Curi	ent @ OE, T/R	$0V \leq V_I \leq 3.6V$	1.65–1.95	3.0-3.6		±5.0	μА
I <sub>OZ</sub>	3-STATE Output Le	akage	$0V \le V_O \le 3.6V$					
			OE* = V <sub>CCB</sub>	1.65-1.95	3.0-3.6		±10	μА
			$V_I = V_{IH}$ or $V_{IL}$					
I <sub>OFF</sub>	Power Off Leakage	Current	$0 \leq (V_I, V_O) \leq 3.6V$	0	0		10	μА
I <sub>CCA</sub> /I <sub>CCB</sub>	Quiescent Supply (	Current,	$A_n = V_{CCA}$ or GND	1.65–1.95	3.0-3.6		20	μА
	per supply, V <sub>CCA</sub> /V	ССВ	$B_n$ , $\overline{OE}$ , & $T/\overline{R} = V_{CCB}$ or GND	1.05-1.55	3.0-3.0		20	μΛ
			$V_{CCA} \le A_n \le 3.6V$	1.65–1.95	3.0-3.6		±20	μА
			$V_{CCB} \le B_n$ , $\overline{OE}$ , $T/\overline{R} \le 3.6V$	1.00-1.00	0.0-0.0			μΛ
$\Delta I_{CC}$	Increase in I <sub>CC</sub> per	Input, B <sub>n</sub> , T/R, OE	$V_I = V_{CCB} - 0.6V$	1.65–1.95	3.0-3.6		750	μА
	Increase in I <sub>CC</sub> per	Input, A <sub>n</sub>	$V_I = V_{CCA} - 0.6V$	1.65–1.95	3.0-3.6		750	μА

# DC Electrical Characteristics (2.3V < $V_{CCA} \leq$ 2.7V, 3.0V $\leq$ $V_{CCB} \leq$ 3.6V)

Symbol	Parameter		Conditions	V <sub>CCA</sub> (V)	V <sub>CCB</sub> (V)	Min	Max	Units
V <sub>IHA</sub>	HIGH Level Input Voltage	A <sub>n</sub>		2.3–2.7	3.0-3.6	1.6		V
$V_{IHB}$		B <sub>n</sub> , T/R, OE		2.3-2.7	3.0-3.6	2.0		V
V <sub>ILA</sub>	LOW Level Input Voltage	A <sub>n</sub>		2.3-2.7	3.0-3.6		0.7	V
$V_{ILB}$		B <sub>n</sub> , T/R, ŌE		2.3-2.7	3.0-3.6		0.8	V
V <sub>OHA</sub>	HIGH Level Output Voltag	e	I <sub>OH</sub> = -100 μA	2.3-2.7	3.0-3.6	V <sub>CCA</sub> -0.2		V
			$I_{OH} = -18 \text{ mA}$	2.3	3.0-3.6	1.7		V
V <sub>OHB</sub>	HIGH Level Output Voltag	е	I <sub>OH</sub> = -100 μA	2.3-2.7	3.0-3.6	V <sub>CCB</sub> -0.2		v
			$I_{OH} = -24 \text{ mA}$	2.3–2.7	3.0	2.2		
V <sub>OLA</sub>	LOW Level Output Voltage	9	I <sub>OL</sub> = 100 μA	2.3–2.7	3.0-3.6		0.2	V
			$I_{OL} = 18 \text{ mA}$	2.3	3.0-3.6		0.6	
V <sub>OLB</sub>	LOW Level Output Voltage		I <sub>OL</sub> = 100 μA	2.3–2.7	3.0-3.6		0.2	V
			$I_{OL} = 24 \text{ mA}$	2.3–2.7	3.0		0.55	V
I <sub>I</sub>	Input Leakage Current @	OE, T/R	$0V \leq V_I \leq 3.6V$	2.3-2.7	3.0-3.6		±5.0	μА
l <sub>OZ</sub>	3-STATE Output Leakage @ A <sub>n</sub>		$\frac{\text{OV} \leq \text{V}_{\text{O}} \leq 3.6\text{V}}{\text{OE}} = \text{V}_{\text{CCA}}$ $\text{V}_{\text{I}} = \text{V}_{\text{IH}} \text{ or V}_{\text{IL}}$	2.3–2.7	3.0-3.6		±10	μА
l <sub>OFF</sub>	Power OFF Leakage Curr	ent	$0 \le (V_I, V_O) \le 3.6V$	0	0		10	μА
I <sub>CCA</sub> /I <sub>CCB</sub>	Quiescent Supply Current per supply, V <sub>CCA</sub> /V <sub>CCB</sub>	,	$A_n = V_{CCA}$ or GND $B_n$ , $\overline{OE}$ , & $T/\overline{R} = V_{CCB}$ or GND	2.3–2.7	3.0-3.6		20	μА
			$\label{eq:VCCA} \begin{split} \hline V_{CCA} & \leq A_n \leq 3.6V \\ V_{CCB} & \leq B_n, \ \overline{OE}, \ T/\overline{R} \leq 3.6V \end{split}$	2.3–2.7	3.0-3.6		±20	μА
$\Delta I_{CC}$	Increase in I <sub>CC</sub> per Input, I	B <sub>n</sub> , T/R, OE	$V_I = V_{CCB} - 0.6V$	2.3-2.7	3.0-3.6		750	μА
	Increase in I <sub>CC</sub> per Input,	A <sub>n</sub>	$V_{I} = V_{CCA} - 0.6V$	2.3-2.7	3.0-3.6		750	μΑ

# **AC Electrical Characteristics**

			$C_L = 30$ pF, $R_L = 500\Omega$ , $T_A = -40$ °C to $+85$ °C,					
Symbol	Parameter	V <sub>CCA</sub> = 1.6	65V to 1.95V	V <sub>CCA</sub> = 1.6	5V to 1.95V	V <sub>CCA</sub> = 2.	3V to 2.7V	Units
Symbol	Farameter	V <sub>CCB</sub> = 2	.3V to 2.7V	V <sub>CCB</sub> = 3.0V to 3.6V		V <sub>CCB</sub> = 3.0V to 3.6V		Units
		Min	Max	Min	Max	Min	Max	
t <sub>PHL</sub> , t <sub>PLH</sub>	Propagation Delay, A to B	0.8	5.5	0.6	5.1	0.6	4.0	ns
t <sub>PHL</sub> , t <sub>PLH</sub>	Propagation Delay, B to A	1.5	5.8	1.5	6.2	0.8	4.4	ns
t <sub>PZL</sub> , t <sub>PZH</sub>	Output Enable Time, OE to B	0.8	5.3	0.6	5.1	0.6	4.0	ns
$t_{PZL}, t_{PZH}$	Output Enable Time, OE to A	1.5	8.3	1.5	8.2	0.8	4.6	ns
$t_{PLZ}, t_{PHZ}$	Output Disable Time, OE to B	0.8	5.2	0.8	5.6	0.8	4.8	ns
$t_{PLZ}$ , $t_{PHZ}$	Output Disable Time, OE to A	0.8	4.6	0.8	4.5	0.8	4.4	ns
t <sub>osHL</sub>	Output to Output Skew		0.5		0.5		0.75	ns
t <sub>osLH</sub>	(Note 8)		0.5		0.5		0.73	113

Note 8: Skew is defined as the absolute value of the difference between the actual propagation delay for any two separate outputs of the same device. The specification applies to any outputs switching in the same direction, either HIGH-to-LOW (t<sub>osHL</sub>) or LOW-to-HIGH (t<sub>osLH</sub>).

# **Dynamic Switching Characteristics**

Symbol	Parameter	Conditions	V <sub>CCA</sub>	V <sub>CCB</sub>	$T_A = 25^{\circ}C$	Units
Syllibol	Farameter	Conditions	(V)	(V)	Typical	Ullis
V <sub>OLP</sub>	Quiet Output Dynamic Peak V <sub>OL</sub> ,	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	2.5	0.25	
	B to A		1.8	3.3	0.25	V
			2.5	3.3	0.6	
	Quiet Output Dynamic Peak V <sub>OL</sub> ,	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	2.5	0.6	
	A to B		1.8	3.3	0.8	V
			2.5	3.3	0.8	
V <sub>OLV</sub>	Quiet Output Dynamic Valley V <sub>OL</sub> ,	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	2.5	-0.25	
	B to A		1.8	3.3	-0.25	V
			2.5	3.3	-0.6	
	Quiet Output Dynamic Valley V <sub>OL</sub> ,	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	2.5	-0.6	
	A to B		1.8	3.3	-0.8	V
			2.5	3.3	-0.8	
V <sub>OHV</sub>	Quiet Output Dynamic Valley V <sub>OH</sub> ,	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	2.5	1.7	
	A to B		1.8	3.3	2.0	V
			2.5	3.3	2.0	
	Quiet Output Dynamic Valley V <sub>OH</sub> ,	$C_L = 30 \text{ pF}, V_{IH} = V_{CC}, V_{IL} = 0V$	1.8	2.5	1.3	
	B to A		1.8	3.3	1.3	V
			2.5	3.3	1.7	

# Capacitance

Symbol	Parameter	Conditions	$T_A = +25^{\circ}C$	Units
Cymbol	T diameter	Conditions	Typical	
C <sub>IN</sub>	Input Capacitance	$V_{CCA} = 2.5V$ , $V_{CCB} = 3.3V$ , $V_I = 0V$ or $V_{CCA/B}$	5	pF
C <sub>I/O</sub>	Input/Output Capacitance	$V_{CCA} = 2.5V$ , $V_{CCB} = 3.3V$ , $V_{I} = 0V$ or $V_{CCA/B}$	6	pF
C <sub>PD</sub>	Power Dissipation Capacitance	$V_{CCA} = 2.5V$ , $V_{CCB} = 3.3V$ , $V_{I} = 0V$ or $V_{CCA/B}$ f = 10 MHz	20	pF

# **AC Loading and Waveforms**

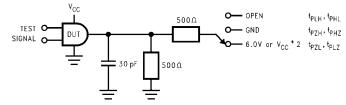


FIGURE 1. AC Test Circuit

TEST	SWITCH	
t <sub>PLH</sub> , t <sub>PHL</sub>	OPEN	
t <sub>PZL</sub> , t <sub>PLZ</sub>	6V at $V_{CC}$ = 3.3 ± 0.3V; $V_{CC}$ x 2 at $V_{CC}$ = 2.5 ± 0.2V; 1.8V ± 0.15V	
t <sub>PZH</sub> , t <sub>PHZ</sub>	GND	

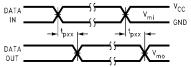


FIGURE 2. Waveform for Inverting and Non-inverting Functions  $t_R=t_F \leq 2.0 \ ns, \ 10\% \ to \ 90\%$ 

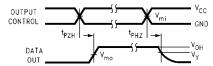


FIGURE 3. 3-STATE Output High Enable and Disable Times for Low Voltage Logic  $t_R=t_F\leq 2.0$  ns, 10% to 90%

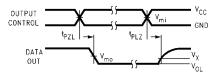
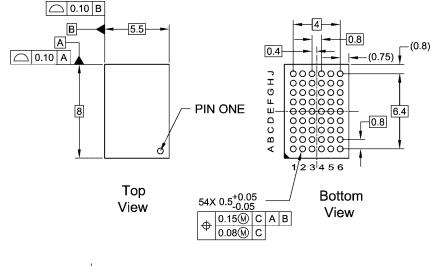
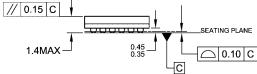


FIGURE 4. 3-STATE Output Low Enable and Disable Times for Low Voltage Logic  $t_R$  =  $t_F \le 2.0$  ns, 10% to 90%

Symbol	V <sub>CC</sub>			
Cyllibol	3.3V ± 0.3V	2.5V ± 0.2V	1.8V ± 0.15V	
V <sub>mi</sub>	1.5V	V <sub>CC</sub> /2	V <sub>CC</sub> /2	
V <sub>mo</sub>	1.5V	V <sub>CC</sub> /2	V <sub>CC</sub> /2	
V <sub>X</sub>	V <sub>OL</sub> + 0.3V	V <sub>OL</sub> + 0.15V	V <sub>OL</sub> + 0.15V	
V <sub>Y</sub>	V <sub>OH</sub> – 0.3V	V <sub>OH</sub> – 0.15V	V <sub>OH</sub> – 0.15V	

# Physical Dimensions inches (millimeters) unless otherwise noted



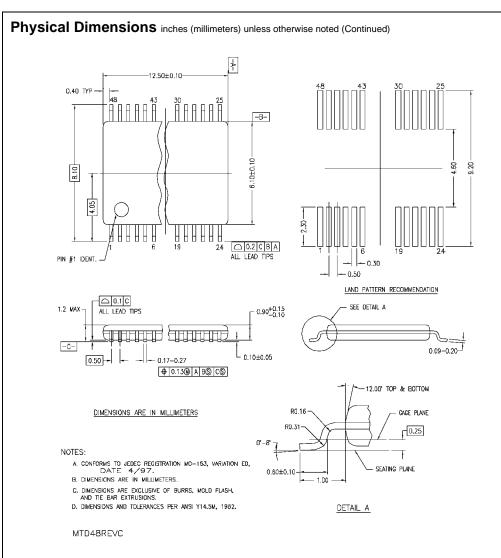


#### NOTES:

- A. THIS PACKAGE CONFORMS TO JEDEC M0-205
- **B. ALL DIMENSIONS IN MILLIMETERS**
- C. LAND PATTERN RECOMMENDATION: NSMD (Non Solder Mask Defined)
  .35MM DIA PADS WITH A SOLDERMASK OPENING OF .45MM CONCENTRIC TO PADS
  D. DRAWING CONFORMS TO ASME Y14.5M-1994

# BGA54ArevD

54-Ball Fine-Pitch Ball Grid Array (FBGA), JEDEC MO-205, 5.5mm Wide Package Number BGA54A



48-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide Package Number MTD48

Fairchild does not assume any responsibility for use of any circuitry described, no circuit patent licenses are implied and Fairchild reserves the right at any time without notice to change said circuitry and specifications.

#### LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF THE PRESIDENT OF FAIRCHILD SEMICONDUCTOR CORPORATION. As used herein:

- Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body, or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury to the user.
- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

www.fairchildsemi.com

ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdt/Patent-Marking.pdf">www.onsemi.com/site/pdt/Patent-Marking.pdf</a>. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and exp

# **PUBLICATION ORDERING INFORMATION**

#### LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

# **Mouser Electronics**

**Authorized Distributor** 

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

**ON Semiconductor:** 



Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

# Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001:
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

**Телефон:** 8 (812) 309 58 32 (многоканальный)

Факс: 8 (812) 320-02-42

Электронная почта: <u>org@eplast1.ru</u>

Адрес: 198099, г. Санкт-Петербург, ул. Калинина,

дом 2, корпус 4, литера А.